

STK24N4LLF5

N-channel 40 V, 0.0046 Ω, 24 A, PolarPAK[®] STripFET™V Power MOSFET

Preliminary Data

Features

Туре	V _{DSS}	R _{DS(on)} max	R _{DS(on)} *Q _g
STK24N4LLF5	40 V	< 0.0055 Ω	96 nC*mΩ

- Ultra low top and bottom junction to case thermal resistance
- R_{DS(on)} * Q_g industry benchmark
- Extremely low on-resistance R_{DS(on)}
- Very low switching gate charge
- Fully encapsulated die
- 100% matte tin finish (in compliance with the 2002/95/EC european directive)
- High avalanche ruggedness
- PolarPAK[®] is a trademark of VISHAY

Application

Switching applications

Description

This product utilizes the 5th generation of design rules of ST's proprietary STripFETTM technology. The lowest available $R_{DS(on)}^*Q_g$, in this chip scale package, makes this device suitable for the most demanding DC-DC converter applications, where high power density is to be achieved.

PolarPAK [®]

Figure 1. Internal schematic diagram



Order code	Marking	Package	Packaging
STK24N4LLF5	244L5	PolarPAK [®]	Tape and reel

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1 Electrical ratings

Table 2. Absolute maximum rating

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage ($V_{GS} = 0$)	40	V
V _{GS}	Gate-source voltage	± 22	V
I _D ⁽¹⁾	Drain current (continuous) at $T_C = 25 \text{ °C}$	24	А
I _D	Drain current (continuous) at T _C = 100 °C	15.3	Α
I _{DM} ⁽²⁾	Drain current (pulsed)	96	Α
P _{TOT} ⁽¹⁾	Total dissipation at $T_C = 25 \ ^{\circ}C$	5.2	W
	Derating factor	0.0416	W/°C
E _{AS} ⁽³⁾	Single pulse avalanche energy	TBD	J
T _j T _{stg}	Operating junction temperature Storage temperature	-55 to 150	°C

1. When mounted on FR-4 board of 1inch², 2 oz Cu and \leq 10sec

2. Pulse width limited by package

3. Starting T_J = 25 °C, I_D = 12 A, V_{DD} = 25 V

Table 3. Thermal data

Symbol	Parameter	Тур.	Max.	Unit
Rthj-amb ⁽¹⁾	Thermal resistance junction-amb	20	24	°C/W
Rthj-c ⁽²⁾	Thermal resistance junction-case (top drain)	1	1.2	°C/W
Rthj-c ⁽³⁾	Thermal resistance junction-case (source)	2.8	3.4	°C/W

1. When mounted on FR-4 board of 1inch², 2 oz Cu and \leq 10sec

2. Steady state

3. Measured at source pin when the device is mounted on FR-4 board in steady state



2 Electrical characteristics

(T_{CASE} = 25 °C unless otherwise specified)

	On/on states					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$I_D = 250 \ \mu A, \ V_{GS} = 0$	40			۷
I _{DSS}	Zero gate voltage drain current ($V_{GS} = 0$)	V _{DS} = Max rating, V _{DS} = Max rating,Tc=125°C			1 10	μΑ μΑ
I _{GSS}	Gate body leakage current $(V_{DS} = 0)$	$V_{GS} = \pm 22 V$			±100	nA
V _{GS(th)}	Gate threshold voltage	V_{DS} = V_{GS} , I_D = 250 μ A	1		2.5	V
R _{DS(on)}	Static drain-source on resistance	V _{GS} = 10 V, I _D = 12 A V _{GS} = 4.5 V, I _D = 12 A		0.0046 0.0058	0.0055 0.0065	Ω Ω

Table 4. On/off states

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V _{DS} =25 V, f=1 MHz, V _{GS} =0		2350 335 50		pF pF pF
Qg	Total gate charge	V _{DD} =15 V, I _D = 24 A		20		nC
Q _{gs}	Gate-source charge	V _{DD} =15 V, I _D = 24 A V _{GS} =4.5 V		TBD		nC
Q _{gd}	Gate-drain charge	(see Figure 3)		TBD		nC
R _G	Gate input resistance	f=1 MHz Gate DC Bias = 0 Test signal level = 20 mV open drain		TBD		Ω

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Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)} t _r	Turn-on delay time Rise time	V_{DD} = 15 V, I _D = 12 A, R _G =4.7 Ω , V _{GS} =4.5 V (see Figure 2)		TBD TBD		ns ns
t _{d(off)} t _f	Turn-off delay time Fall time	$V_{DD}=15 \text{ V}, \text{ I}_{D}=12 \text{ A},$ $R_{G}=4.7 \Omega, \text{ V}_{GS}=4.5 \text{ V}$ (see Figure 2)		TBD TBD		ns ns

Table 6.Switching times

Table 7.Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD} I _{SDM} ⁽¹⁾	Source-drain current Source-drain current (pulsed)				24 96	A A
V _{SD} ⁽²⁾	Forward on Voltage	I _{SD} = 24 A, V _{GS} =0			1.1	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	I _{SD} = 24 A, di/dt = 100 A/µs, V _{DD} =20 V, Tj=150 °C <i>(se Figure 7)</i>		TBD TBD TBD		ns nC A

1. Pulse width limited by package

2. Pulsed: pulse duration = $300\mu s$, duty cycle 1.5%

3 Test circuits

Figure 2. Switching times test circuit for resistive load





Gate charge test circuit

Figure 3.

Figure 4. Test circuit for inductive load F switching and diode recovery times





Figure 6. Unclamped inductive waveform



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Figure 8. Gate charge waveform





4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK® is an ST trademark.



Dim.	mm			
	Min.	Тур.	Max.	
А	0.75	0.80	0.85	
A1			0.05	
b1	0.48	0.58	0.68	
b2	0.41	0.51	0.61	
b3	2.19	2.29	2.39	
b4	0.89	1.04	1.19	
b5	0.23	0.33	0.43	
С	0.20	0.25	0.30	
D	6	6.15	6.30	
D1	5.74	5.89	6.04	
E	5.01	5.16	5.31	
E1	4.75	4.90	5.05	
H1	0.23	0.38		
H2	0.45	0.51	0.56	
H3	0.31	0.41	0.51	
H4	0.45	0.51	0.56	
K1	4.22	4.37	4.52	
K2	1.08	1.13	1.18	
K3	1.37			
K4	0.24			
M1	4.30	4.50	4.70	
M2	3.43	3.58	3.73	
М3	0.22			
M4	0.05			
P1	0.15	0.20	0.25	
T1	3.48	3.64	4.10	
T2	0.56	0.76	0.95	
Т3	1.20			
T4	3.90			
T5		0.18	0.36	
<	0°	10°	12°	

 Table 8.
 PolarPAK® option "S" mechanical data





Figure 9. PolarPAK® option "S" drawing



5 Revision history

Table 9. Document revision history

Date	Revision	Changes
19-Jan-2009	1	First release



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